

MOS FIELD EFFECT TRANSISTOR

NP86N04CHE,NP86N04DHE,NP86N04EHE,NP86N04KHE

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance $R_{DS(on)} = 4.4 \text{ m}\Omega$ MAX. (Vgs = 10 V, ID = 43 A)
- Low Ciss: Ciss = 5900 pF TYP.
- Built-in gate protection diode

ORDERING INFORMATION

PART NUMBER	PACKAGE
NP86N04CHE	TO-220AB
NP86N04DHE	TO-262
NP86N04EHE	TO-263 (MP-25ZJ)
NP86N04KHE	TO-263 (MP-25ZK)

(TO-220AB)



(TO-262)



(TO-263)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	40	V
Gate to Source Voltage (Vps = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C) Note1	I _{D(DC)}	±86	Α
Drain Current (Pulse) Note2	ID(pulse)	±344	Α
Total Power Dissipation (Tc = 25°C)	Рт	230	W
Total Power Dissipation (T _A = 25°C)	Рт	1.8	W
Channel Temperature	Tch	175	°C
Storage Temperature	Tstg	-55 to +175	°C
Single Avalanche Current Note3	las	86 / 67 / 24	Α
Single Avalanche Energy Note3	Eas	74 / 450 / 580	mJ

Notes 1. Calculated constant current according to MAX. allowable channel temperature.

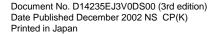
- **2.** PW \leq 10 μ s, Duty cycle \leq 1%
- 3. Starting T_{ch} = 25°C, V_{DD} = 20 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V (see Figure 4.)

THERMAL RESISTANCE

Channel to Case Thermal Resistance	Rth(ch-C)	0.65	°C/W
Channel to Ambient Thermal Resistance	Rth(ch-A)	83.3	°C/W

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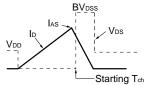


ELECTRICAL CHARACTERISTICS (TA = 25°C)

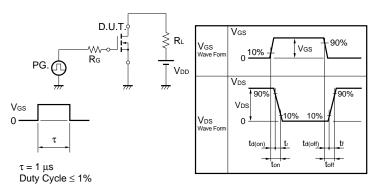
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Ipss	V _{DS} = 40 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	lgss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Gate to Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	2.0	3.0	4.0	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 43 A	29	57		S
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, ID = 43 A		3.5	4.4	mΩ
Input Capacitance	Ciss	V _{DS} = 25 V		5900	8900	pF
Output Capacitance	Coss	V _G S = 0 V		1200	1800	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		530	960	pF
Turn-on Delay Time	td(on)	V _{DD} = 20 V, I _D = 43 A		32	71	ns
Rise Time	tr	Vgs = 10 V		24	59	ns
Turn-off Delay Time	t _{d(off)}	R _G = 1 Ω		110	220	ns
Fall Time	tr			33	82	ns
Total Gate Charge	Q _G	V _{DD} = 32 V		110	170	nC
Gate to Source Charge	Qgs	V _G S = 10 V		22		nC
Gate to Drain Charge	Q _{GD}	ID = 86 A		36		nC
Body Diode Forward Voltage	V _F (S-D)	IF = 86 A, VGS = 0 V		0.93		V
Reverse Recovery Time	trr	IF = 86 A, VGS = 0 V		70		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		125		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

$V_{GS} = 20 \rightarrow 0 \text{ V}$ $PG. \longrightarrow S_{M} \longrightarrow S_{M}$



TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE

$$\begin{array}{c|c} D.U.T. \\ \hline I_G = 2 \text{ mA} \\ \hline W \\ \hline \end{array} \begin{array}{c} \downarrow \\ \downarrow \\ \downarrow \\ \downarrow \\ \end{matrix} \end{array} \begin{array}{c} RL \\ \hline \\ V_{DD} \end{array}$$

TYPICAL CHARACTERISTICS (TA = 25°C)

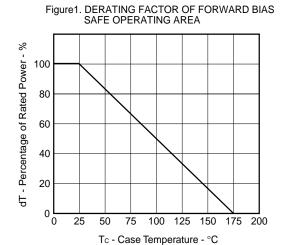
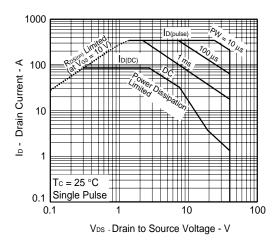
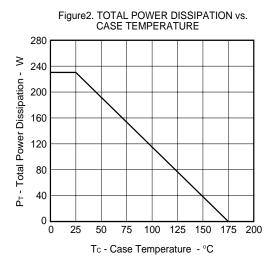


Figure 3. FORWARD BIAS SAFE OPERATING AREA





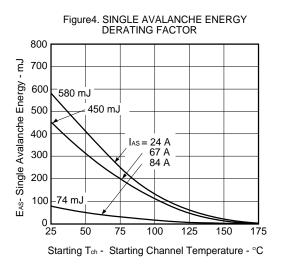


Figure 5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH 1000 r_{th(t)} - Transient Thermal Resistance - °C/W 100 $R_{th(ch-A)} = 83.3^{\circ}C/W$ 10 $R_{th(ch-C)} = 0.65^{\circ}C/W$ 0.1 Single Pulse $Tc = 25^{\circ}C$ 0.01 100 1000 100 m 10 10μ 100μ 1 m 10 m

PW - Pulse Width - s

Figure 6. FORWARD TRANSFER CHARACTERISTICS

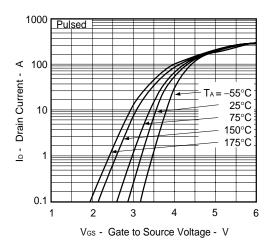


Figure 8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

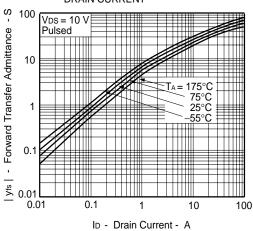


Figure 10. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

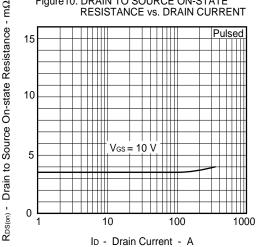
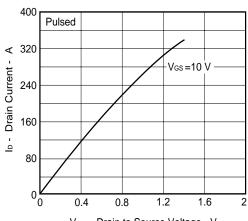


Figure 7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



V_{DS} - Drain to Source Voltage - V

Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

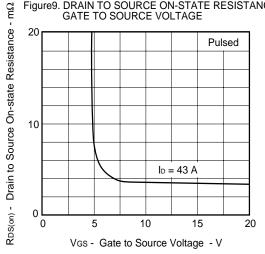
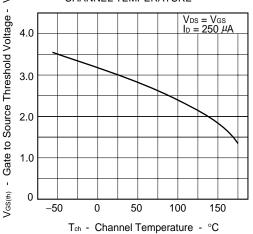


Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE



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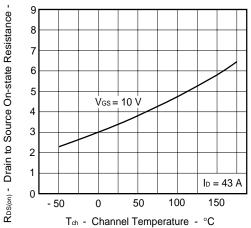


Figure 14. CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

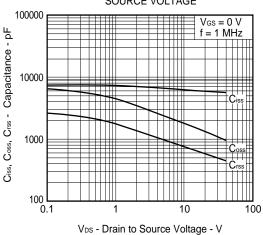


Figure 16. REVERSE RECOVERY TIME vs. DRAIN CURRENT

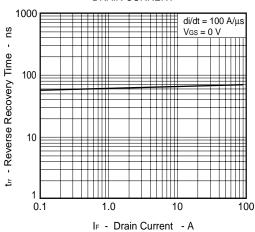


Figure 13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE

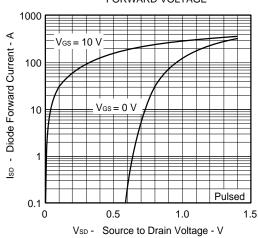


Figure 15. SWITCHING CHARACTERISTICS

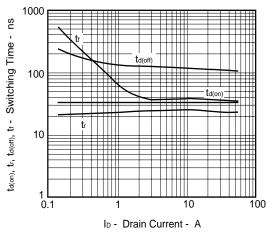
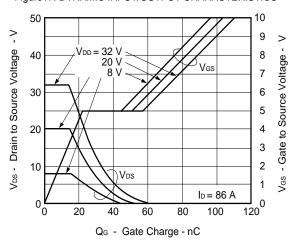
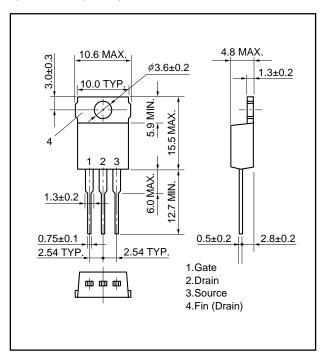


Figure 17. DYNAMIC INPUT/OUTPUT CHARACTERISTICS

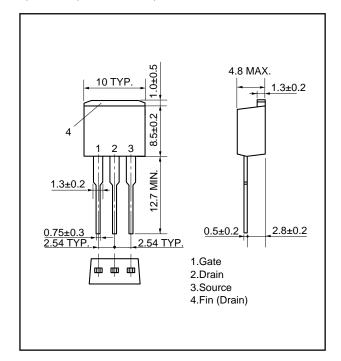


PACKAGE DRAWINGS (Unit: mm)

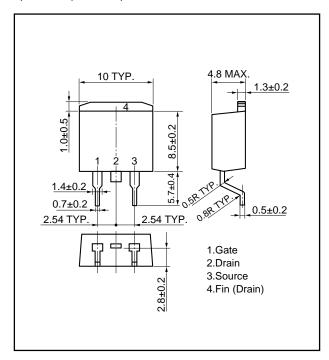
1) TO-220AB (MP-25)



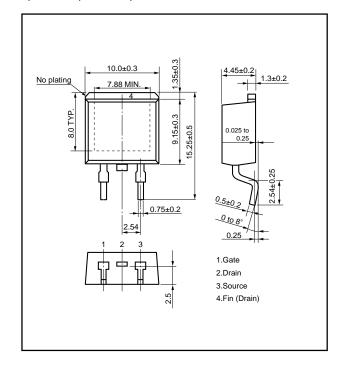
2) TO-262 (MP-25 Fin Cut)



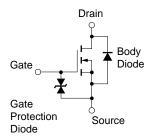
3) TO-263 (MP-25ZJ)



★ 4) TO-263 (MP-25ZK)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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